

Notice of References Cited	Application/Control No. 10/707,877	Applicant(s)/Patent Under Reexamination LONG, J. WAYNE	
	Examiner <i>K.A.</i> Kamran Afshar, 571-272-7796	Art Unit 2681	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,539,301 B1	03-2003	Shirk et al.	701/200
	B	US-5,905,467	05-1999	Narayanaswamy et al.	343/702
	C	US-6,044,257	03-2000	Boling et al.	455/404.2
	D	US-6,282,436 B1	08-2001	Crisp, Martin	455/575.4
	E	US-6,151,485	11-2000	Crisp, Martin	455/575.4
	F	US-6,332,074 B1	12-2001	Spitaletta et al.	455/410
	G	US-5,845,218	12-1998	Altschul, Randice-Lisa	455/565
	H	US-6,243,022	06-2001	Furukawa, Hideo	340/825.72
	I	US-6,285,867 B1	09-2001	Boling et al.	455/404.1
	J	US-6,028,514	02-2000	Lemelson et al.	340/539.13
	K	US-2002/0008610 A1	01-2002	Peterson, John	340/5.64
	L	US-2002/0084893 A1	07-2002	Eisenman, Robert C.	340/426
	M	US-6,035,217	03-2000	Kravitz, Scott	455/561

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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